## NSN 6625-01-297-0967

Repairability:

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•		
Shelf Life:		
N/a		
Unit Of Measure:		
1 ea		
Demilitarization:		
No		
Fiig:		
T228-a		
Hazmat:		
Ves		

When repair is beyond lower level maintenance capability, evacuate the item to depot. disposal is not authorized below wholesale level.